10771553 CLS

Most Frequently Occurring Classifications of Patents Returned From A Search of 10771553 on May 27, 2004

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17 250/288
 5 204/452
 5 210/198.2
 3 204/453
 3 216/2
 3 250/281
 2 204/451
 2 204/603
 2 210/656
 2 216/79
Cross-Reference Classifications
20 250/288
14 250/281
14 250/282
10 210/748
 9 210/243
 8 204/603
 7 204/600
 7 204/601
 7 210/198.2
 7 210/656
 5 250/423R
 5 438/743
 4 204/452
 4 204/604
 4 438/723
 3 216/67
 3 216/79
 3 250/292
 3 436/161
 3 438/734
 3 438/736
 3 438/942
 2 204/450
 2 204/451
 2 216/39
 2 216/47
 2 216/80
 2 422/70
 2 436/173
 2 436/174
 2 436/177
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Original Classifications

10771553 CLS

- 2 436/86
- 2 436/87
- 2 436/89
- 2 436/91
- 2 436/93
- 2 436/94
- 2 438/756

Combined Classifications

- 37 250/288
- 250/281 17
- 14 250/282
- 12 210/198.2
- 10 204/603
- 10 210/748
 - 204/452 9
 - 9 210/243
 - 9 210/656
 - 8 204/601
 - 7 204/600
 - 5 216/79
 - 5 250/423R
 - 5 438/743
 - 4 204/451
 - 4 204/453
 - 4 204/604
 - 4 438/723
 - 3 216/2
 - 3 216/67
 - 3 250/292
 - 3 436/161
 - 3 436/173
 - 3 438/734
 - 3 438/736 3
 - 438/942
 - 2 204/450
 - 2 216/39
 - 2 216/47
 - 2 216/80
 - 2 250/289
 - 2 422/70
 - 2 436/174
 - 2 436/177
 - 2 436/86
 - 2 436/87
 - 2 436/89
 - 2 436/91
 - 436/93

2 436/942 438/756

10771553 CLSTITLES

Titles of Most Frequently Occurring Classifications of Patents Returne d

From A Search of 10771553 on May 27, 2004

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(17 OR, 20 XR)
 37
     250/288
          Class
                  250 : RADIANT ENERGY
          250/281
                        IONIC SEPARATION OR ANALYSIS
          250/288
                        .With sample supply means
 17
     250/281
                   (3 OR, 14 XR)
                  250 : RADIANT ENERGY
          250/281
                        IONIC SEPARATION OR ANALYSIS
 14
    250/282
                   (0 OR, 14 XR)
                  250 : RADIANT ENERGY
          Class
          250/281
                        IONIC SEPARATION OR ANALYSIS
          250/282
                        .Methods
 12
   210/198.2
                   (5 OR, 7 XR)
                  210 : LIQUID PURIFICATION OR SEPARATION
          Class
          210/198.1
                        WITH MEANS TO ADD TREATING MATERIAL
          210/198.2
                        .Chromatography
 10 204/603
                   (2 OR, 8 XR)
                  204 : CHEMISTRY:
                                     ELECTRICAL AND WAVE ENERGY
          Class
          204/193
                        APPARATUS
          204/600
                        .Electrophoretic or electro-osmotic apparatus
          204/601
                        .. Capillary electrophoresis type
          204/603
                        ...With detailed detection system (e.g.,
                           including a light source and a camera, etc.
)
 10
    210/748
                   (0 OR, 10 XR)
                  210 : LIOUID PURIFICATION OR SEPARATION
          Class
          210/600
                        PROCESSES
          210/748
                        .Utilizing electrical or wave energy (directly
                           applied to liquid or material being treated
)
     204/452
                   (5 OR, 4 XR)
                  204: CHEMISTRY: ELECTRICAL AND WAVE ENERGY
          Class
          204/450
                        .Electrophoresis or electro-osmosis processes
                             and electrolyte compositions therefor whe
n not provided for
                             elsewhere
          204/451
                        .. Capillary electrophoresis
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10771553 CLSTITLES

...With detailed detection 204/452

9. 210/243 (0 OR, 9 XR)

> Class 210: LIQUID PURIFICATION OR SEPARATION 210/243 ELECTRICAL INSULATING OR ELECTRICITY DISCHARGING

(2 OR, 7 XR) 9 210/656

Class 210: LIQUID PURIFICATION OR SEPARATION

210/600 PROCESSES

210/656 .Chromatography

8 204/601 (1 OR, 7 XR)

Class 204: CHEMISTRY: ELECTRICAL AND WAVE ENERGY

204/193 APPARATUS

204/600 .Electrophoretic or electro-osmotic apparatus

204/601 ..Capillary electrophoresis type

7 204/600 (0 OR, 7 XR)

Class 204: CHEMISTRY: ELECTRICAL AND WAVE ENERGY

204/193

APPARATUS
.Electrophoretic or electro-osmotic apparatus 204/600

5 216/79 (2 OR, 3 XR)

Class 216: ETCHING A SUBSTRATE: PROCESSES 216/58 GAS PHASE ETCHING OF SUBSTRATE

216/74 .Etching inorganic substrate

216/79 .. Etching silicon containing substrate

5 250/423R (0 OR, 5 XR)

> Class 250 : RADIANT ENERGY 250/423R ION GENERATION

5 438/743 (0 OR, 5 XR)

Class 438: SEMICONDUCTOR DEVICE MANUFACTURING: PROCESS

438/689 CHEMICAL ETCHING

438/706 .Vapor phase etching (i.e., dry etching)

438/735 ..Differential etching of semiconductor

substrate

438/737 ... Substrate possessing multiple layers

438/743Silicon oxide or glass

4 204/451 (2 OR, 2 XR)

Class 204: CHEMISTRY: ELECTRICAL AND WAVE ENERGY

204/450 .Electrophoresis or electro-osmosis processes

10771553 CLSTITLES and electrolyte compositions therefor when not provided for elsewhere 204/451 .. Capillary electrophoresis 204/453 (3 OR, 1 XR) 204 : CHEMISTRY: ELECTRICAL AND WAVE ENERGY .Electrophoresis or electro-osmosis processes 204/450 and electrolyte compositions therefor whe n not provided for elsewhere 204/451 .. Capillary electrophoresis 204/453 ...With injection 204/604 (0 OR, 4 XR) 204 : CHEMISTRY: ELECTRICAL AND WAVE ENERGY Class 204/193 **APPARATUS** 204/600 .Electrophoretic or electro-osmotic apparatus 204/601 .. Capillary electrophoresis type 204/604 ...With injector 438/723 (0 OR, 4 XR) 438 : SEMICONDUCTOR DEVICE MANUFACTURING: PROCESS Class 438/689 CHEMICAL ETCHING 438/706 .Vapor phase etching (i.e., dry etching) 438/707 ..Utilizing electromagnetic or wave energy ... By creating electric field (e.g., plasma, 438/710 glow discharge, etc.) 438/723Silicon oxide or glass 216/2 (3 OR, 0 XR) 216 : ETCHING A SUBSTRATE: Class PROCESSES ETCHING OF SEMICONDUCTOR MATERIAL TO PRODUCE A 216/2 Ν ARTICLE HAVING A NONELECTRICAL FUNCTION 216/67 (0 OR, 3 XR) 216 : ETCHING A SUBSTRATE: Class PROCESSES 216/58 GAS PHASE ETCHING OF SUBSTRATE 216/63 .Application of energy to the gaseous etchant or to the substrate being etched 216/67 .. Using plasma

Page 3

IONIC SEPARATION OR ANALYSIS

(0 OR, 3 XR)

250 : RADIANT ENERGY

250/292

Class

250/281

			10771553 CLSTITLES
	250/290		.Cyclically varying ion selecting field means
	250/292		Laterally resonant ion path
3	436/161 Class		OR, 3 XR) : CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING
	436/161		
3	436/173 Class		OR, 2 XR) : CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING
	436/173		NUCLEAR MAGNETIC RESONANCE, ELECTRON SPIN RESONANCE OR OTHER SPIN EFFECTS OR MASS SPE
CTRO	OMETRY		RESONANCE ON STILL BITECTS ON THIS STE
3	438/734 Class	-	OR, 3 XR) : SEMICONDUCTOR DEVICE MANUFACTURING: PROCESS
	438/689 438/706 438/734		.Vapor phase etching (i.e., dry etching)
3	438/736 Class		OR, 3 XR) : SEMICONDUCTOR DEVICE MANUFACTURING: PROCESS
	438/689 438/706 438/735		CHEMICAL ETCHING .Vapor phase etching (i.e., dry etching)Differential etching of semiconductor
	438/736		<pre>substrateUtilizing multilayered mask</pre>
3	438/942. Class		OR, 3 XR) : SEMICONDUCTOR DEVICE MANUFACTURING: PROCESS
	438/942		MASKING
2	_ ,		OR, 2 XR) : CHEMISTRY: ELECTRICAL AND WAVE ENERGY .Electrophoresis or electro-osmosis processes and electrolyte compositions therefor when
not	provided for		elsewhere
2	216/39 Class 216/39		OR, 2 XR) : ETCHING A SUBSTRATE: PROCESSES FORMING GROOVE OR HOLE IN A SUBSTRATE WHICH IS SUBSEQUENTLY FILLED OR COATED

10771553_CLSTITLES

Т	2	216/4	Class	216	OR, 2 XR) : ETCHING A SUBSTRATE: PROCESSES MASKING OF A SUBSTRATE USING MATERIAL RESISTAN
1			216/47		TO AN ETCHANT (I.E., ETCH RESIST) .Mask is multilayer resist
	2	216/8		216	OR, 2 XR) : ETCHING A SUBSTRATE: PROCESSES GAS PHASE ETCHING OF SUBSTRATE .Etching inorganic substrateEtching silicon containing substrateSilicon containing substrate is glass
	2	250/2	289 Class 250/281 250/289	250	OR, 1 XR) : RADIANT ENERGY IONIC SEPARATION OR ANALYSIS .With evacuation or sealing means
	2	422/7		422	OR, 2 XR) : CHEMICAL APPARATUS AND PROCESS DISINFECTING, DEODORIZING, PRESERVING, OR STERILIZING ANALYZER, STRUCTURED INDICATOR, OR MANIPULATIV
E			422/68.1 422/69 422/70		LABORATORY DEVICE .Means for analyzing liquid or solid sampleSorption testingLiquid chromatography
	2	436/1	Class	436	OR, 2 XR) : CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING INCLUDING SAMPLE PREPARATION
	2	436/1	Class 436/174	436	OR, 2 XR) : CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING INCLUDING SAMPLE PREPARATION .Liberation or purification of sample or
filtering,					separation of material from a sample (e.g., centrifuging, etc.)
	2	436/8			OR, 2 XR) : CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING PEPTIDE, PROTEIN OR AMINO ACID

Page 5

10771553_CLSTITLES

2	Class	(0 OR, 2 XR) 436: CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING PEPTIDE, PROTEIN OR AMINO ACID .Glycoproteins (e.g., hormone, etc.)
2	436/86	(0 OR, 2 XR) 436: CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING PEPTIDE, PROTEIN OR AMINO ACID .Amino acid or sequencing procedure
2		(0 OR, 2 XR) 436: CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING HETEROCYCLIC CARBON COMPOUND (I.E., 0, S, N, Se, Te, AS ONLY RING HETERO ATOM)
2	Class	(0 OR, 2 XR) 436: CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING HETEROCYCLIC CARBON COMPOUND (I.E., O, S, N, Se, Te, AS ONLY RING HETERO ATOM) .Hetero-O (e.g., ascorbic acid, etc.)
2	436/91	436: CHEMISTRY: ANALYTICAL AND IMMUNOLOGICAL TESTING HETEROCYCLIC CARBON COMPOUND (I.E., O, S, N, Se, Te, AS ONLY RING HETERO ATOM) .Hetero-O (e.g., ascorbic acid, etc.)
2	438/756 Class	(0 OR, 2 XR) 438 : SEMICONDUCTOR DEVICE MANUFACTURING: PROCESS
	438/689 438/745 438/756	CHEMICAL ETCHING .Liquid phase etchingSilicon oxide